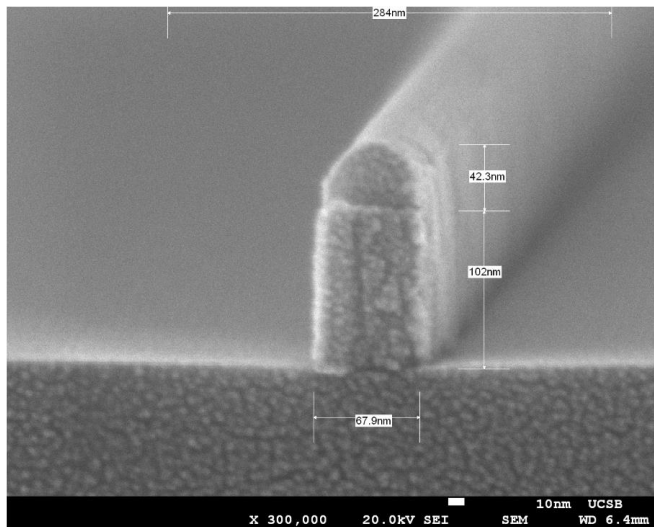
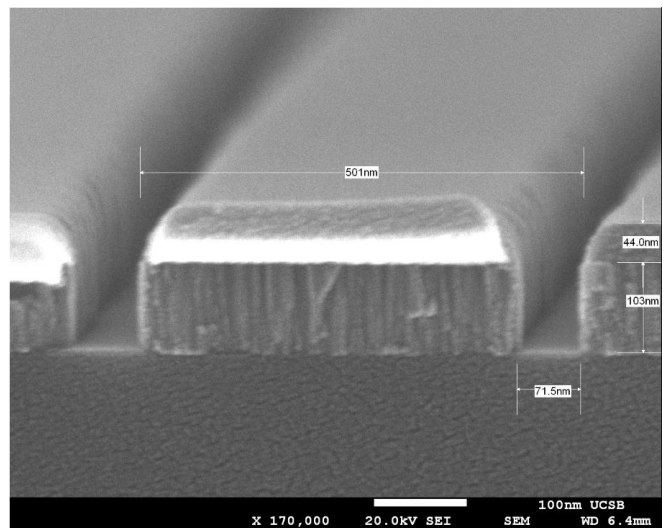
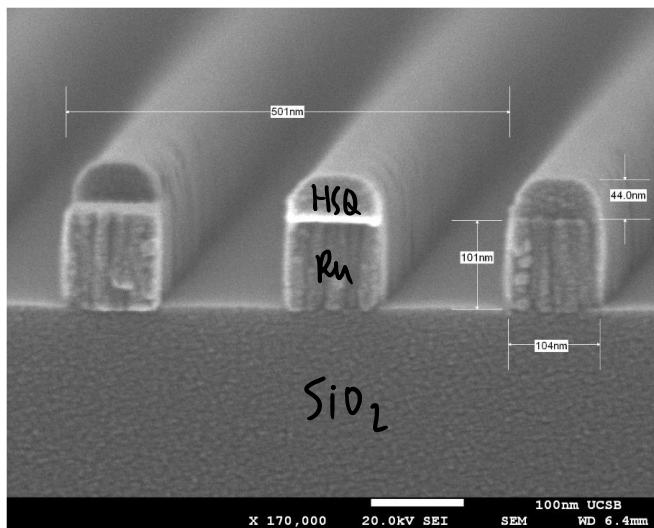


ICP2: recipe = #194 Ru Etch

(developed by Bill Mitchell, Nanofab process group)

<u>Substrate structure</u>		<i>Ru(100-110nm)/SiO₂(2um)/Si</i>
<u>Masking resist</u>		<i>HSQ(~50nm)</i>
<u>Plasma Powers</u>	ICP	<i>500W</i>
	CCP[bias]	<i>50W</i>
<u>Gas Flows</u>	O₂	<i>49.5sccm</i>
	Cl₂	<i>5.5sccm</i>
<u>Gas Pressures</u>	Ignition	<i>0.5Pa</i>
	Etch	<i>2.5Pa</i>
<u>Etch Data</u>		
Etch Rate (via laser monitor)		<i>Ru ~ 85nm/min, HSQ < 10nm/min</i>
Etch angle		<i>~90 degrees (vertical!)</i>



Total etch time = T[end] + T[over] = 1m29ss

- T[end] = laser monitor endpoint = 1m9s
- T[over] = over etch = 20s